

STF20NK50Z, STP20NK50Z

N-channel 500 V, 0.23 Ω 17 A SuperMESH™ Power MOSFET Zener-protected in TO-220FP and TO-220 packages

Datasheet — production data

Features

| Order codes | V _{DSS} | R _{DS(on)} max | I _D | P _{TOT} |
|-------------|------------------|----------------------------|----------------|------------------|
| STF20NK50Z | 500 V | < 0.27 Ω | 17 A | 40 W |
| STP20NK50Z | 500 V | < 0.27 Ω | 17 A | 190 W |

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitance



■ Switching applications

Description

These devices are N-channel Zener-protected Power MOSFETs developed using STMicroelectronics' SuperMESH™ technology, achieved through optimization of ST's well established strip-based PowerMESH™ layout. In addition to a significant reduction in onresistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

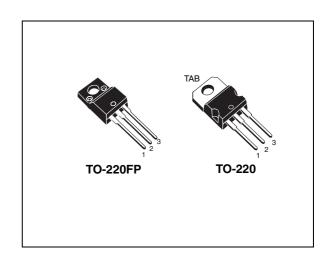


Figure 1. Internal schematic diagram

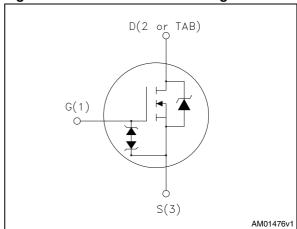


Table 1. Device summary

| Order codes | Marking | Package | Packaging |
|-------------|----------|----------|-----------|
| STF20NK50Z | F20NK50Z | TO-220FP | Tube |
| STP20NK50Z | P20NK50Z | TO-220 | lube |

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | 9 | Unit |
|--|--|------------|----------------------|------|
| Symbol | Parameter | TO-220 | TO-220FP | Unit |
| V _{DS} | Drain-source voltage | 500 | | V |
| V _{GS} | Gate-source voltage | ± 30 |) | V |
| I _D Drain current (continuous) at T _C = 25 °C | | 17 | 17 ⁽¹⁾ | Α |
| I _D Drain current (continuous) at T _C = 100 °C | | 10.71 | 10.71 ⁽¹⁾ | Α |
| I _{DM} ⁽²⁾ | Drain current (pulsed) | 68 | 68 | Α |
| P _{TOT} | Total dissipation at T _C = 25 °C | 190 | 40 | W |
| | Derating factor | 1.52 | 0.32 | W/°C |
| V _{ISO} | V _{ISO} Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; T _C = 25 °C) | | 2500 | V |
| ESD | Gate-source human body model (R=1.5 kΩ C=100 pF) | 6 | | kV |
| dv/dt (3) | Peak diode recovery voltage slope | 4.5 | | V/ns |
| T _{stg} | Storage temperature | -55 to 150 | | °C |
| T _j | Max operating junction temperature | 150 | | °C |

- 1. Limited by maximum junction temperature.
- 2. Pulse width limited by safe operating area.
- $3. \quad I_{SD} \quad \leq 17 \text{ A, di/dt} \quad \leq \ 200 \text{ A/}\mu\text{s, V}_{DD} \quad \leq \ V_{\left(BR\right)DSS}, \, T_{j} \quad \leq T_{JMAX}.$

Table 3. Thermal data

| Symbol | Parameter | Value | • | Unit |
|-----------------------|---|--------|----------|-------|
| Symbol | Farameter | TO-220 | TO-220FP | Oilit |
| R _{thj-case} | Thermal resistance junction-case max | 0.66 | 3.1 | °C/W |
| R _{thj-amb} | Thermal resistance junction-ambient max | 62.5 | 62.5 | °C/W |

Table 4. Avalanche characteristics

| Symbol | Parameter | Value | Unit |
|-----------------|---|-------|------|
| I _{AR} | Avalanche current, repetitive or not- repetitive (pulse width limited by Tj max) | 17 | Α |
| E _{AS} | Single pulse avalanche energy (starting T _J =25 °C, I _D =I _{AR} , V _{DD} =50 V) | 850 | mJ |

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 5. On/off states

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|----------------------|--|---|------|------|---------|--------------------------|
| V _{(BR)DSS} | Drain-source breakdown voltage | I _D =1 mA, V _{GS} = 0 | 500 | | | V |
| I _{DSS} | Zero gate voltage drain current (V _{GS} = 0) | V _{DS} = 500 V V _{DS} = 500 V, T _C = 125 °C | | | 1 50 | μ Α μ Α |
| I _{GSS} | Gate-body leakage current (V _{DS} = 0) | V _{GS} = ± 20 V | | | ± 10 | μΑ |
| V _{GS(th)} | Gate threshold voltage | $V_{DS} = V_{GS}, I_{D} = 100 \mu A$ | 3 | 3.75 | 4.5 | ٧ |
| R _{DS(on)} | Static drain-source on-resistance | $V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}$ | | 0.23 | 0.27 | Ω |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|--|---|--|------|----------------------|------|----------------------|
| C _{iss} C _{oss} C _{rss} | Input capacitance Output capacitance Reverse transfer capacitance | $V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$ | - | 2600 328 72 | | pF pF pF |
| C _{oss eq.} (1) | Equivalent output capacitance | $V_{DS} = 0$, $V_{DS} = 0$ to 640 V | - | 187 | | pF |
| $\begin{array}{c} t_{\text{d(on)}} \\ t_{\text{r}} \\ t_{\text{d(off)}} \\ t_{\text{f}} \end{array}$ | Turn-on delay time Rise time Turn-off delay time Fall time | $V_{DD} = 250 \text{ V}, I_{D} = 8.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 16</i>) | 1 | 28 20 70 15 | | ns ns ns ns |
| Q _g Q _{gs} Q _{gd} | Total gate charge Gate-source charge Gate-drain charge | $V_{DD} = 400 \text{ V}, I_{D} = 17 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 17</i>) | - | 85 15.5 42 | 119 | nC nC nC |

C_{oss eq.} is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}.

Table 7. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|--|--|---|------|-------------------|----------|---------------|
| I _{SD} | Source-drain current Source-drain current (pulsed) | | - | | 17 68 | A A |
| V _{SD} ⁽²⁾ | Forward on voltage | $I_{SD} = 17 \text{ A}, V_{GS} = 0$ | - | | 1.6 | V |
| t _{rr} Q _{rr} I _{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | I_{SD} = 17 A, di/dt = 100 A/µs V_{R} = 100 V (see <i>Figure 18</i>) | - | 355 3.90 22 | | ns μC Α |
| t _{rr} Q _{rr} I _{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | I_{SD} = 17 A, di/dt = 100 A/µs V_{R} = 100 V, Tj = 150 °C (see <i>Figure 18</i>) | - | 440 5.72 26 | | ns μC Α |

- 1. Pulsed: pulse duration=300µs, duty cycle 1.5%
- 2. Pulse width limited by safe operating area

Table 8. Gate-source Zener diode

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|-------------------|-------------------------------|------------------------|------|------|------|------|
| BV _{GSO} | Gate-source breakdown voltage | Igs=± 1mA (open drain) | 30 | - | | ٧ |

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220

10μs 10μs 10μs 100μs 1 ms 10ms

Figure 3. Thermal impedance for TO-220

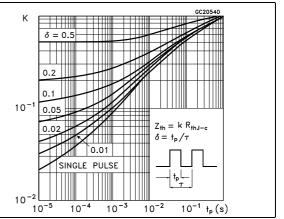


Figure 4. Safe operating area for TO-220FP

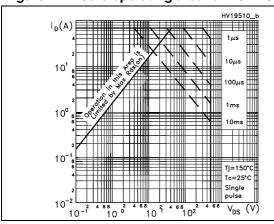


Figure 5. Thermal impedance for TO-220FP

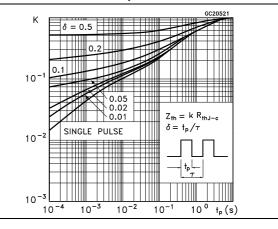


Figure 6. Output characteristics

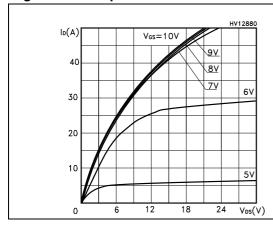
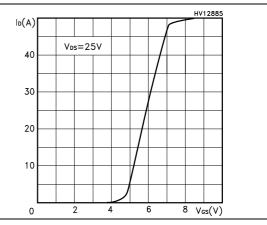
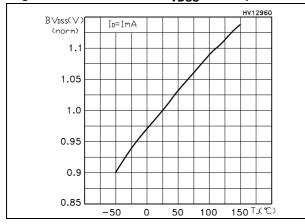


Figure 7. Transfer characteristics



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Figure 8. Normalized B_{VDSS} vs temperature Figure 9. Static drain-source on-resistance



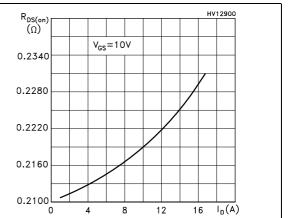
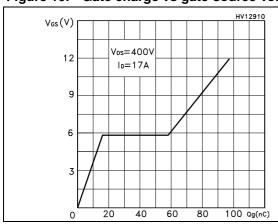


Figure 10. Gate charge vs gate-source voltage Figure 11. Capacitance variations



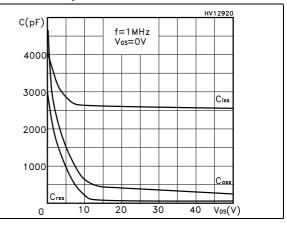
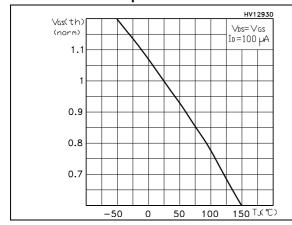


Figure 12. Normalized gate threshold voltage Figure 13. Normalized on-resistance vs vs temperature temperature



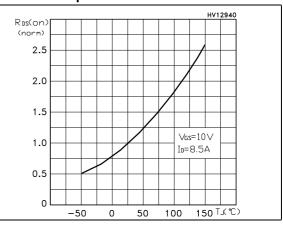
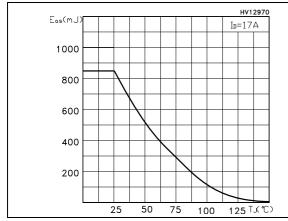
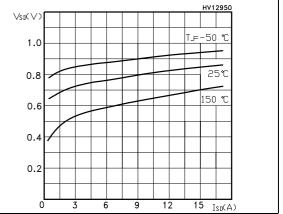


Figure 14. Maximum avalanche energy vs temperature

Figure 15. Source-drain diode forward characteristic





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3 Test circuits

Figure 16. Switching times test circuit for resistive load

Figure 17. Gate charge test circuit

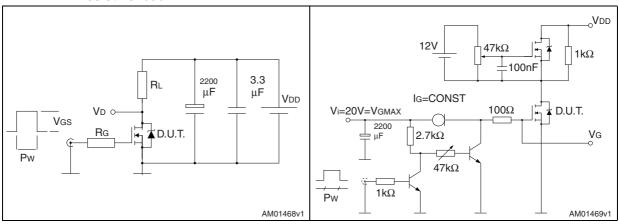


Figure 18. Test circuit for inductive load switching and diode recovery times

Figure 19. Unclamped inductive load test circuit

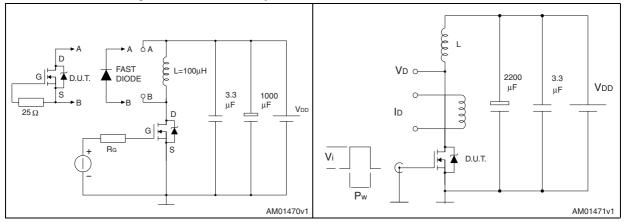
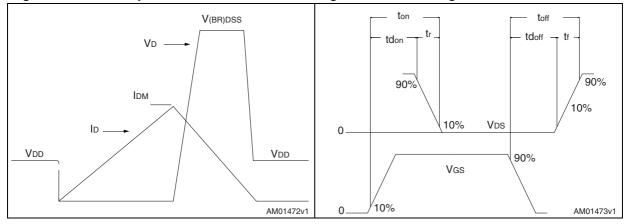


Figure 20. Unclamped inductive waveform

Figure 21. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 9. TO-220FP mechanical data

| Di | mm | | | | |
|------|------|------|------|--|--|
| Dim. | Min. | Тур. | Max. | | |
| А | 4.4 | | 4.6 | | |
| В | 2.5 | | 2.7 | | |
| D | 2.5 | | 2.75 | | |
| Е | 0.45 | | 0.7 | | |
| F | 0.75 | | 1 | | |
| F1 | 1.15 | | 1.70 | | |
| F2 | 1.15 | | 1.70 | | |
| G | 4.95 | | 5.2 | | |
| G1 | 2.4 | | 2.7 | | |
| Н | 10 | | 10.4 | | |
| L2 | | 16 | | | |
| L3 | 28.6 | | 30.6 | | |
| L4 | 9.8 | | 10.6 | | |
| L5 | 2.9 | | 3.6 | | |
| L6 | 15.9 | | 16.4 | | |
| L7 | 9 | | 9.3 | | |
| Dia | 3 | | 3.2 | | |

_B⊸ Dia *L6 L2 L7* L3 F1 **L4** F2 -*E*

Figure 22. TO-220FP drawing

G 1.

7012510_Rev_K_B

Table 10. TO-220 type A mechanical data

| | 10-220 type A mechanical | mm | |
|------|--------------------------|--------|-------|
| Dim. | | 111111 | Г |
| | Min. | Тур. | Max. |
| Α | 4.40 | | 4.60 |
| b | 0.61 | | 0.88 |
| b1 | 1.14 | | 1.70 |
| С | 0.48 | | 0.70 |
| D | 15.25 | | 15.75 |
| D1 | | 1.27 | |
| E | 10 | | 10.40 |
| е | 2.40 | | 2.70 |
| e1 | 4.95 | | 5.15 |
| F | 1.23 | | 1.32 |
| H1 | 6.20 | | 6.60 |
| J1 | 2.40 | | 2.72 |
| L | 13 | | 14 |
| L1 | 3.50 | | 3.93 |
| L20 | | 16.40 | |
| L30 | | 28.90 | |
| ØP | 3.75 | | 3.85 |
| Q | 2.65 | | 2.95 |

D D1 L30 D1 L30

Figure 23. TO-220 type A drawing

5 Revision history

Table 11. Document revision history

| Date | Revision | Changes |
|-------------|----------|----------------|
| 05-Apr-2012 | 1 | First release. |

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